

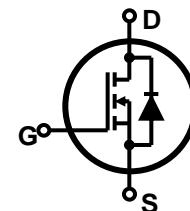
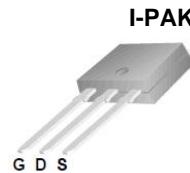
Features

- Low gate charge
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant
- Halogen free package
- JEDEC Qualification

$V_{DSS} = 880 \text{ V} @ T_{jmax}$

$I_D = 3\text{A}$

$R_{DS(on)} = 4.2 \Omega(\text{max}) @ V_{GS} = 10 \text{ V}$



Device	Package	Marking	Remark
TMD3N80G/TMU3N80G	D-PAK/I-PAK	TMD3N80G/TMU3N80G	Halogen Free

Absolute Maximum Ratings

Parameter	Symbol	TMD3N80G/TMU3N80G	Unit
Drain-Source Voltage	V_{DSS}	800	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current $T_C = 25 \text{ }^\circ\text{C}$	I_D	3	A
$T_C = 100 \text{ }^\circ\text{C}$		1.83	A
Pulsed Drain Current (Note 1)	I_{DM}	12	A
Single Pulse Avalanche Energy (Note 2)	E_{AS}	283	mJ
Repetitive Avalanche Current (Note 1)	I_{AR}	3	A
Repetitive Avalanche Energy (Note 1)	E_{AR}	9.4	mJ
Power Dissipation $T_C = 25 \text{ }^\circ\text{C}$	P_D	94	W
Derate above $25 \text{ }^\circ\text{C}$		0.75	W/ $^\circ\text{C}$
Peak Diode Recovery dv/dt (Note 3)	dv/dt	4.5	V/ns
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~150	$^\circ\text{C}$
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	T_L	300	$^\circ\text{C}$

* Limited only by maximum junction temperature

Thermal Characteristics

Parameter	Symbol	TMD3N80G/TMU3N80G	Unit
Maximum Thermal resistance, Junction-to-Case	$R_{\theta JC}$	1.33	$^\circ\text{C}/\text{W}$
Maximum Thermal resistance, Junction-to-Ambient	$R_{\theta JA}$	110	$^\circ\text{C}/\text{W}$

Electrical Characteristics : $T_c=25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test condition	Min	Typ	Max	Units
OFF						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}} = 0 \text{ V}, I_{\text{D}} = 250 \mu\text{A}$	800	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 800 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	10	μA
		$V_{\text{DS}} = 640 \text{ V}, T_c = 125^\circ\text{C}$	--	--	100	μA
Forward Gate-Source Leakage Current	I_{GSSF}	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
Reverse Gate-Source Leakage Current	I_{GSSR}	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA
ON						
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250 \mu\text{A}$	2	--	4	V
Drain-Source On-Resistance	$R_{\text{DS(on)}}$	$V_{\text{GS}} = 10 \text{ V}, I_{\text{D}} = 1.5 \text{ A}$	--	3.36	4.2	Ω
Forward Transconductance ^(Note 4)	g_{FS}	$V_{\text{DS}} = 30 \text{ V}, I_{\text{D}} = 1.5 \text{ A}$	--	3.7	--	S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	696	--	pF
Output Capacitance	C_{oss}		--	65	--	pF
Reverse Transfer Capacitance	C_{rss}		--	10.2	--	pF
SWITCHING						
Turn-On Delay Time ^(Note 4,5)	$t_{\text{d(on)}}$	$V_{\text{DD}} = 400 \text{ V}, I_{\text{D}} = 3 \text{ A}, R_{\text{G}} = 25 \Omega$	--	48	--	ns
Turn-On Rise Time ^(Note 4,5)	t_r		--	36	--	ns
Turn-Off Delay Time ^(Note 4,5)	$t_{\text{d(off)}}$		--	106	--	ns
Turn-Off Fall Time ^(Note 4,5)	t_f		--	41	--	ns
Total Gate Charge ^(Note 4,5)	Q_g	$V_{\text{DS}} = 640 \text{ V}, I_{\text{D}} = 3 \text{ A}, V_{\text{GS}} = 10 \text{ V}$	--	19	--	nC
Gate-Source Charge ^(Note 4,5)	Q_{gs}		--	4	--	nC
Gate-Drain Charge ^(Note 4,5)	Q_{gd}		--	7.6	--	nC
SOURCE DRAIN DIODE						
Maximum Continuous Drain-Source Diode Forward Current	I_s	----	--	--	3	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}	----	--	--	12	A
Drain-Source Diode Forward Voltage	V_{SD}	$V_{\text{GS}} = 0 \text{ V}, I_s = 3 \text{ A}$	--	--	1.5	V
Reverse Recovery Time ^(Note 4)	t_{rr}	$V_{\text{GS}} = 0 \text{ V}, I_s = 3 \text{ A}$	--	372	--	ns
Reverse Recovery Charge ^(Note 4)	Q_{rr}		--	1.8	--	μC

Note :

1. Repeated rating : Pulse width limited by safe operating area
2. $L = 59\text{mH}$, $I_{AS} = 3\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{SD} \leq 3\text{A}$, $dI/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DS}$, Starting $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
5. Essentially Independent of Operating Temperature Typical Characteristics

